Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	ï
10/751,305	HEIN ET AL.	
Examiner	Art Unit	
B Chen	1762	

	SEARCHED			
Class	Subclass	Date	Examiner	
updated	previous	10/1/2006	вс	
		-		
		-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	J			

S (INCLUDIN	EARCH NO	TES STRATEGY	)
		DATE	EXMR
east		10/1/2006	вс